SHEET_1 OF 1 INFORMATION DISCLOSURE MAR 16 2007
STATEMENT BY APPLICANT
(Use several sheets if necessary) ATTY. DOCKET NO. FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office SERIAL NO. L8612.03108 10/719,061 APPLICANT Hisao KOGA, et al FILING DATE November 24, 2003 **GROUP** Unassigned **U.S. PATENT DOCUMENTS** FXAMINER IF THE PROPRIETE CLASS DOCUMENT NUMBER DATE NAME /AF/ 6 9 5 4 10/2005 **Peeters FOREIGN PATENT DOCUMENTS** DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS TRANSLATION YES NO /AF/ 2001 9 8 4 3 9 10/2001 JP **Abstract** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Japanese Office Action dated November 22, 2006 with English translation.

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/Aristocratis Fotakis/

DATE CONSIDERED

08/14/2007

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